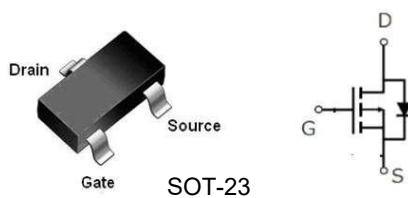


P-Channel PowerTrench®MOSFET

-20V, -4A, 43mΩ

Features

- $R_{DS(ON)} = 43\text{m}\Omega$ @ $V_{GS} = -4.5\text{ V}$
- $R_{DS(ON)} = 54\text{m}\Omega$ @ $V_{GS} = -2.5\text{ V}$



Order Information

| Product | Package | Marking | Packing | Min Unit Quantity |
|-----------|---------|---------|--------------|-------------------|
| IRLML6402 | SOT-23 | AF4* | 3000PCS/Reel | 3000PCS |

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|----------------|------------|-------|
| Drain-Source Voltage | V_{DS} | -20 | V |
| Gate-Source Voltage | V_{GS} | ± 8 | V |
| Continuous Drain Current ^A | I_D | -4.0 | A |
| $T_A=70^\circ\text{C}$ | | -3.5 | |
| Pulsed Drain Current ^B | I_{DM} | -30 | |
| Power Dissipation ^A | P_D | 1.4 | W |
| $T_A=70^\circ\text{C}$ | | 0.9 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | °C |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 65 | 90 | °C/W |
| Maximum Junction-to-Ambient ^A | | 85 | 125 | °C/W |
| Maximum Junction-to-Lead ^C | $R_{\theta JL}$ | 43 | 60 | °C/W |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|--|------|-------|----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=-250\mu\text{A}, V_{GS}=0\text{V}$ | -20 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=-16\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | -1 | μA |
| | | | | | -5 | |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm 4.5\text{V}$ | | | ± 1 | μA |
| | | $V_{DS}=0\text{V}, V_{GS}=\pm 8\text{V}$ | | | ± 10 | μA |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=-250\mu\text{A}$ | -0.3 | -0.55 | -1 | |
| $I_{D(\text{ON})}$ | On state drain current | $V_{GS}=-4.5\text{V}, V_{DS}=-5\text{V}$ | -25 | | | A |
| $R_{DS(\text{ON})}$ | Static Drain-Source On-Resistance | $V_{GS}=-4.5\text{V}, I_D=-4\text{A}$ $T_J=125^\circ\text{C}$ | | 35 | | $\text{m}\Omega$ |
| | | $V_{GS}=-2.5\text{V}, I_D=-4\text{A}$ | | 48 | | |
| | | $V_{GS}=-1.8\text{V}, I_D=-2\text{A}$ | | 45 | | $\text{m}\Omega$ |
| | | | | 56 | | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=-5\text{V}, I_D=-4\text{A}$ | 8 | 16 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=-1\text{A}, V_{GS}=0\text{V}$ | | -0.78 | -1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | -2.2 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=-10\text{V}, f=1\text{MHz}$ | | 1450 | | pF |
| C_{oss} | Output Capacitance | | | 205 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 160 | | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | | 6.5 | | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q_g | Total Gate Charge | $V_{GS}=-4.5\text{V}, V_{DS}=-10\text{V}, I_D=-4\text{A}$ | | 17.2 | | nC |
| Q_{gs} | Gate Source Charge | | | 1.3 | | nC |
| Q_{gd} | Gate Drain Charge | | | 4.5 | | nC |
| $t_{D(\text{on})}$ | Turn-On Delay Time | $V_{GS}=-4.5\text{V}, V_{DS}=-10\text{V}, R_L=2.5\Omega, R_{\text{GEN}}=3\Omega$ | | 9.5 | | ns |
| t_r | Turn-On Rise Time | | | 17 | | ns |
| $t_{D(\text{off})}$ | Turn-Off Delay Time | | | 94 | | ns |
| t_f | Turn-Off Fall Time | | | 35 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=-4\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 31 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=-4\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 13.8 | | nC |

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

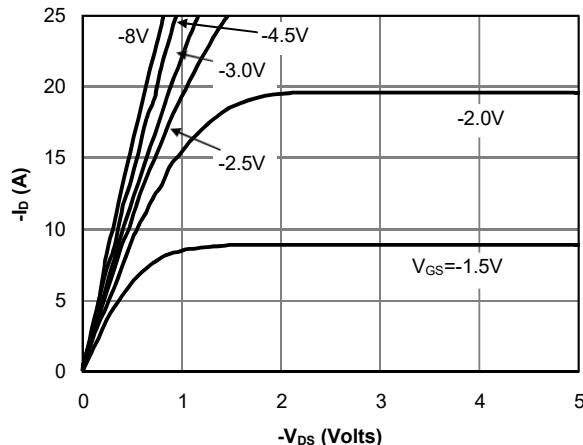


Fig 1: On-Region Characteristics

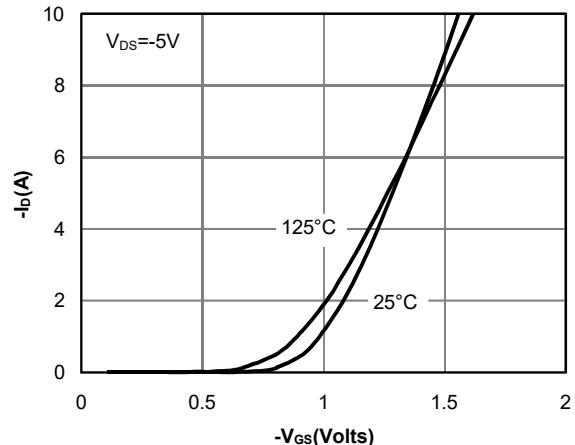


Figure 2: Transfer Characteristics

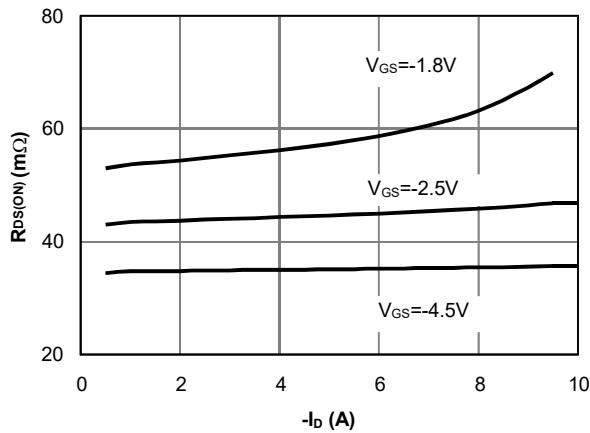


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

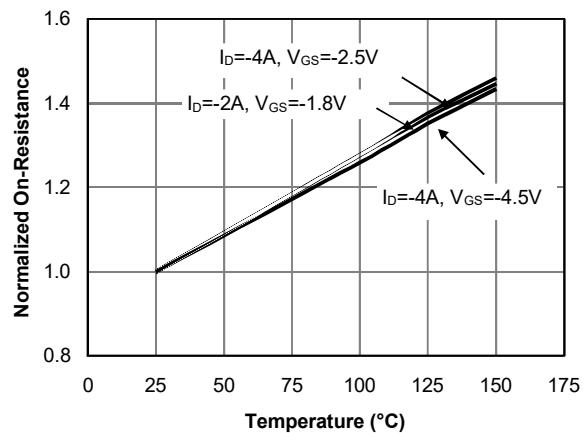


Figure 4: On-Resistance vs. Junction Temperature

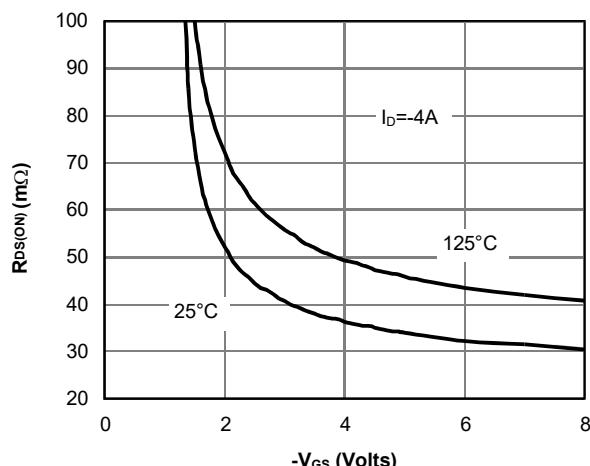


Figure 5: On-Resistance vs. Gate-Source Voltage

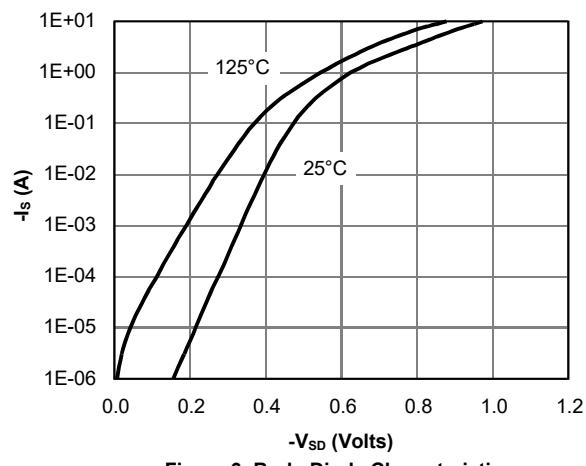


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

